## PSMN023-40YLC

N-channel 40 V 23m $\Omega$  logic level MOSFET in LFPAK using NextPower technology

22 August 2012

**Product data sheet** 

### 1. Product profile

### 1.1 General description

Logic level enhancement mode N-channel MOSFET in LFPAK package. This product is designed and qualified for use in a wide range of industrial, communications and domestic equipment.

#### 1.2 Features and benefits

- High reliability Power SO8 package, qualified to 175°C
- Low parasitic inductance
- Optimised for 4.5V Gate drive utilising NextPower Superjunction technology
- Ultra low QG, QGD, & QOSS for high system efficiencies at low and high loads

### 1.3 Applications

- DC-to-DC converters
- · Load switching
- Server power supplies
- Synchronous buck regulator

#### 1.4 Quick reference data

Table 1. Quick reference data

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V <sub>DS</sub>	drain-source voltage	25 °C ≤ T <sub>j</sub> ≤ 175 °C	-	-	40	V
I <sub>D</sub>	drain current	T <sub>mb</sub> = 25 °C; V <sub>GS</sub> = 10 V; <u>Fig. 1</u>	-	-	24	Α
P <sub>tot</sub>	total power dissipation	T <sub>mb</sub> = 25 °C; <u>Fig. 2</u>	-	-	25	W
T <sub>j</sub>	junction temperature		-55	-	175	°C
Static charact	eristics					
R <sub>DSon</sub>	drain-source on-state resistance	$V_{GS}$ = 4.5 V; $I_D$ = 5 A; $T_j$ = 25 °C; Fig. 12	-	22	26	mΩ
		$V_{GS}$ = 10 V; $I_D$ = 5 A; $T_j$ = 25 °C; Fig. 12	-	19	23	mΩ
Dynamic char	acteristics					
$Q_{GD}$	gate-drain charge	$V_{GS}$ = 4.5 V; $I_D$ = 5 A; $V_{DS}$ = 20 V; Fig. 14; Fig. 15	-	0.9	-	nC





Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Q <sub>G(tot)</sub>	total gate charge	$V_{GS} = 4.5 \text{ V}; I_D = 5 \text{ A}; V_{DS} = 20 \text{ V};$	-	4.3	-	nC
		Fig. 14; Fig. 15				

## 2. Pinning information

Table 2. Pinning information

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	S	source	mb	D I
2	S	source		
3	S	source	[d]	G 4
4	G	gate	<u>o o o o</u>	mbb076 S
mb	D	mounting base; connected to drain	1 2 3 4 LFPAK; Power- SO8 (SOT669)	

## 3. Ordering information

Table 3. Ordering information

•						
Type number	Package					
	Name	Description	Version			
PSMN023-40YLC	LFPAK; Power-SO8	plastic single-ended surface-mounted package; 4 leads	SOT669			

## 4. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Parameter	Conditions	Min	Max	Unit
drain-source voltage	25 °C ≤ T <sub>j</sub> ≤ 175 °C	-	40	V
drain-gate voltage	25 °C ≤ $T_j$ ≤ 175 °C; $R_{GS}$ = 20 kΩ	-	40	V
gate-source voltage		-20	20	V
drain current	V <sub>GS</sub> = 10 V; T <sub>mb</sub> = 25 °C; <u>Fig. 1</u>	-	24	Α
	V <sub>GS</sub> = 10 V; T <sub>mb</sub> = 100 °C; <u>Fig. 1</u>	-	17	Α
peak drain current	pulsed; $t_p \le 10 \mu s$ ; $T_{mb} = 25 ^{\circ}C$ ; Fig. 4	-	97	Α
total power dissipation	T <sub>mb</sub> = 25 °C; <u>Fig. 2</u>	-	25	W
storage temperature		-55	175	°C
junction temperature		-55	175	°C
peak soldering temperature		-	260	°C
electrostatic discharge voltage	MM (JEDEC JESD22-A115)	100	-	V
	drain-gate voltage gate-source voltage drain current  peak drain current total power dissipation storage temperature junction temperature peak soldering temperature electrostatic discharge voltage		$ \begin{array}{llllllllllllllllllllllllllllllllllll$	$ \begin{array}{cccccccccccccccccccccccccccccccccccc$

Symbol	Parameter	Conditions	Min	Max	Unit
Source-drain	diode				·
Is	source current	T <sub>mb</sub> = 25 °C	-	23	Α
I <sub>SM</sub>	peak source current	pulsed; $t_p \le 10 \ \mu s$ ; $T_{mb} = 25 \ ^{\circ}C$	-	97	Α
Avalanche ru	ggedness			'	
E <sub>DS(AL)S</sub>	non-repetitive drain-source avalanche energy	$V_{GS}$ = 10 V; $T_{j(init)}$ = 25 °C; $I_{D}$ = 24 A; $V_{sup} \le$ 40 V; $R_{GS}$ = 50 Ω; unclamped; Fig. 3	-	6.9	mJ

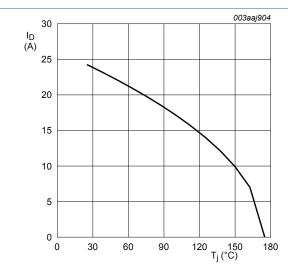


Fig. 1. Continuous drain current as a function of mounting base temperature

$$V_{GS} \! \geq \! 10V$$

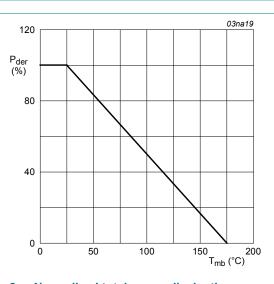


Fig. 2. Normalized total power dissipation as a function of mounting base temperature

$$P_{der} = \frac{P_{tot}}{P_{tot(25^{\circ}C)}} \times 100\%$$

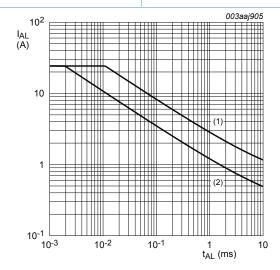
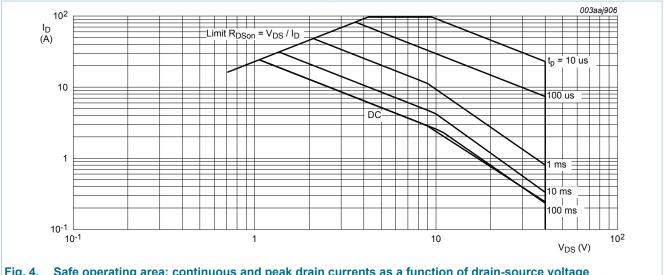


Fig. 3. Single pulse avalanche rating; avalanche current as a function of avalanche time

(1) 
$$T_{j (ini)} = 25^{\circ}C$$
; (2)  $T_{j (ini)} = 100^{\circ}C$ 

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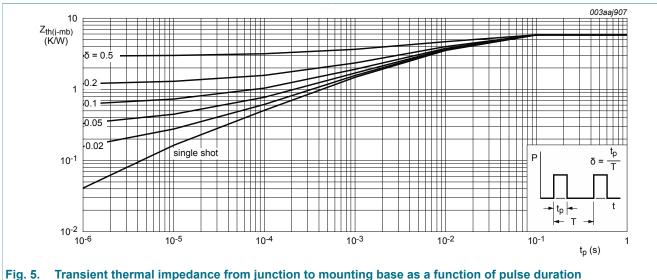
Safe operating area; continuous and peak drain currents as a function of drain-source voltage

 $T_{mb} = 25^{\circ}C$ ;  $I_{DM}$  is a single pulse

### Thermal characteristics

Table 5. Thermal characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
R <sub>th(j-mb)</sub>	thermal resistance from junction to mounting base	Fig. 5	-	5.66	5.83	K/W



### 6. Characteristics

Table 6. Characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static chara	acteristics					
V <sub>(BR)DSS</sub>	drain-source	$I_D$ = 250 $\mu$ A; $V_{GS}$ = 0 V; $T_j$ = 25 °C	40	-	-	V
breakd	breakdown voltage	I <sub>D</sub> = 250 μA; V <sub>GS</sub> = 0 V; T <sub>j</sub> = -55 °C	36	-	-	V
V <sub>GS(th)</sub>	gate-source threshold voltage	$I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = 25 \text{ °C};$ Fig. 10	1.05	1.67	1.95	V
		I <sub>D</sub> = 10 mA; V <sub>DS</sub> = V <sub>GS</sub> ; T <sub>j</sub> = 150 °C; Fig. 11	0.5	-	-	V
		$I_D$ = 1 mA; $V_{DS}$ = $V_{GS}$ ; $T_j$ = -55 °C; Fig. 11	-	-	2.25	V
I <sub>DSS</sub>	drain leakage current	V <sub>DS</sub> = 40 V; V <sub>GS</sub> = 0 V; T <sub>j</sub> = 25 °C	-	-	1	μΑ
		V <sub>DS</sub> = 40 V; V <sub>GS</sub> = 0 V; T <sub>j</sub> = 150 °C	-	-	100	μA
I <sub>GSS</sub>	gate leakage current	V <sub>GS</sub> = 16 V; V <sub>DS</sub> = 0 V; T <sub>j</sub> = 25 °C	-	-	100	nA
	V <sub>GS</sub> = -16 V; V <sub>DS</sub> = 0 V; T <sub>j</sub> = 25 °C	-	-	100	nA	
R <sub>DSon</sub>	drain-source on-state resistance	$V_{GS}$ = 4.5 V; $I_D$ = 5 A; $T_j$ = 25 °C; Fig. 12	-	22	26	mΩ
		V <sub>GS</sub> = 4.5 V; I <sub>D</sub> = 5 A; T <sub>j</sub> = 150 °C; Fig. 12; Fig. 13	-	-	44.5	mΩ
		V <sub>GS</sub> = 10 V; I <sub>D</sub> = 5 A; T <sub>j</sub> = 25 °C; <u>Fig. 12</u>	-	19	23	mΩ
		V <sub>GS</sub> = 10 V; I <sub>D</sub> = 5 A; T <sub>j</sub> = 150 °C; Fig. 12; Fig. 13	-	-	39.5	mΩ
R <sub>G</sub>	gate resistance	f = 1 MHz	0.85	1.7	3.4	Ω
Dynamic ch	naracteristics		l			
Q <sub>G(tot)</sub>	total gate charge	I <sub>D</sub> = 5 A; V <sub>DS</sub> = 20 V; V <sub>GS</sub> = 10 V; Fig. 14; Fig. 15	-	8.4	-	nC
		I <sub>D</sub> = 5 A; V <sub>DS</sub> = 20 V; V <sub>GS</sub> = 4.5 V; Fig. 14; Fig. 15	-	4.3	-	nC
		I <sub>D</sub> = 0 A; V <sub>DS</sub> = 0 V; V <sub>GS</sub> = 10 V	-	8	-	nC
Q <sub>GS</sub>	gate-source charge	I <sub>D</sub> = 5 A; V <sub>DS</sub> = 20 V; V <sub>GS</sub> = 4.5 V;	-	1.3	-	nC
Q <sub>GS(th)</sub>	pre-threshold gate- source charge	Fig. 14; Fig. 15	-	0.7	-	nC
Q <sub>GS(th-pl)</sub>	post-threshold gate- source charge		-	0.6	-	nC
$Q_{GD}$	gate-drain charge		-	0.9	-	nC
V <sub>GS(pl)</sub>	gate-source plateau voltage	I <sub>D</sub> = 5 A; V <sub>DS</sub> = 20 V; <u>Fig. 14</u> ; <u>Fig. 15</u>	-	2.5	-	V

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Symbol	Parameter	Conditions	Min	Тур	Max	Unit
C <sub>iss</sub>	input capacitance	$V_{DS} = 20 \text{ V}; V_{GS} = 0 \text{ V}; f = 1 \text{ MHz};$ $T_j = 25 \text{ °C}; Fig. 16$	-	520	-	pF
C <sub>oss</sub>	output capacitance		-	110	-	pF
C <sub>rss</sub>	reverse transfer capacitance		-	40	-	pF
t <sub>d(on)</sub>	turn-on delay time	$V_{DS} = 20 \text{ V}; R_L = 4 \Omega; V_{GS} = 4.5 \text{ V};$	-	6.2	-	ns
t <sub>r</sub>	rise time	$R_{G(ext)} = 5 \Omega$	-	3.8	-	ns
t <sub>d(off)</sub>	turn-off delay time		-	9.9	-	ns
t <sub>f</sub>	fall time		-	3.1	-	ns
Q <sub>oss</sub>	output charge	$V_{GS} = 0 \text{ V}; V_{DS} = 20 \text{ V}; f = 1 \text{ MHz};$ $T_j = 25 ^{\circ}\text{C}$	-	3.4	-	nC
Source-dr	ain diode		l			
$V_{SD}$	source-drain voltage	$I_S = 5 \text{ A}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ °C}; Fig. 17$	-	0.83	1.1	V
t <sub>rr</sub>	reverse recovery time	$I_S = 5 \text{ A}; dI_S/dt = -100 \text{ A/}\mu\text{s}; V_{GS} = 0 \text{ V};$	-	12.9	-	ns
Q <sub>r</sub>	recovered charge	V <sub>DS</sub> = 20 V	-	6.9	-	nC
t <sub>a</sub>	reverse recovery rise time	$V_{GS} = 0 \text{ V}; I_S = 5 \text{ A}; dI_S/dt = -100 \text{ A/}\mu\text{s};$ $V_{DS} = 20 \text{ V}; Fig. 18$	-	8.7	-	ns
t <sub>b</sub>	reverse recovery fall time		-	4.2	-	ns

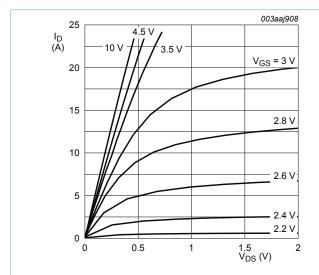


Fig. 6. Output characteristics; drain current as a function of drain-source voltage; typical values

 $T_j = 25$ °C

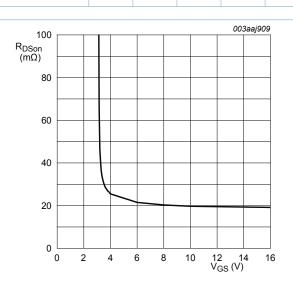


Fig. 7. Drain-source on-state resistance as a function of gate-source voltage; typical values

$$T_j = 25^{\circ}C; I_D = 5A$$

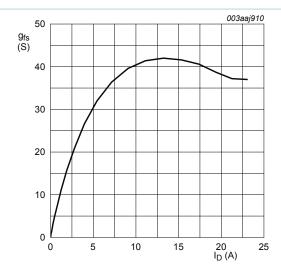


Fig. 8. Forward transconductance as a function of drain current; typical values

$$T_j = 25$$
°C;  $V_{DS} = 10V$ 

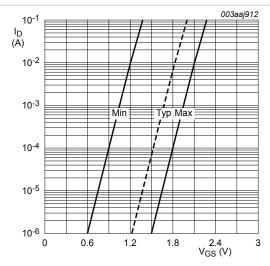


Fig. 10. Sub-threshold drain current as a function of gate-source voltage

$$T_j = 25^{\circ}C; \ V_{DS} = 5V$$

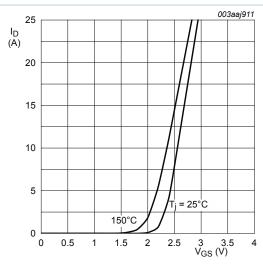


Fig. 9. Transfer characteristics; drain current as a function of gate-source voltage; typical values

$$V_{DS} = 10V$$

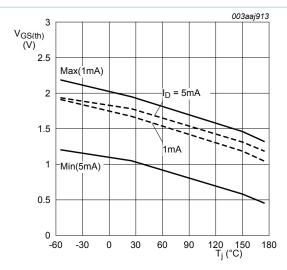


Fig. 11. Gate-source threshold voltage as a function of junction temperature

$$V_{DS} = V_{GS}$$

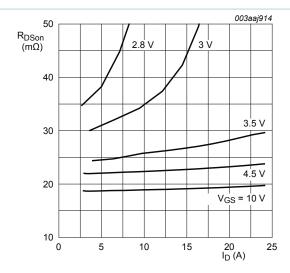


Fig. 12. Drain-source on-state resistance as a function of drain current; typical values

$$T_j = 25^{\circ}C$$

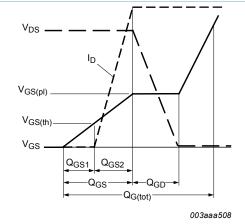


Fig. 14. Gate charge waveform definitions

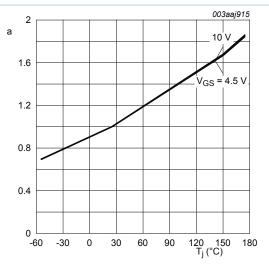


Fig. 13. Normalized drain-source on-state resistance factor as a function of junction temperature

$$a = \frac{R_{DSon}}{R_{DSon (25^{\circ}C)}}$$

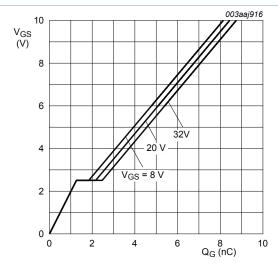


Fig. 15. Gate-source voltage as a function of gate charge; typical values

$$T_j = 25^{\circ}C; I_D = 5A$$

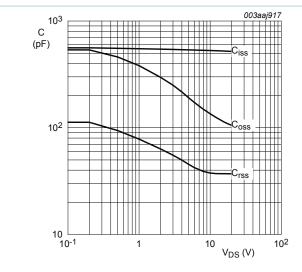
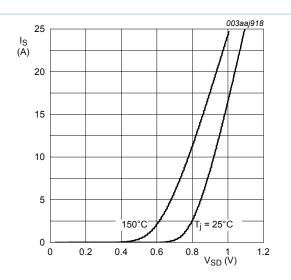


Fig. 16. Input, output and reverse transfer capacitances | Fig. 17. Source current as a function of source-drain as a function of drain-source voltage; typical values

$$V_{GS} = \mathbf{0}V; f = \mathbf{1}MHz$$



voltage; typical values

$$V_{GS} = 0V$$

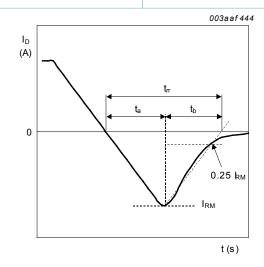


Fig. 18. Reverse recovery timing definition

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## 7. Package outline

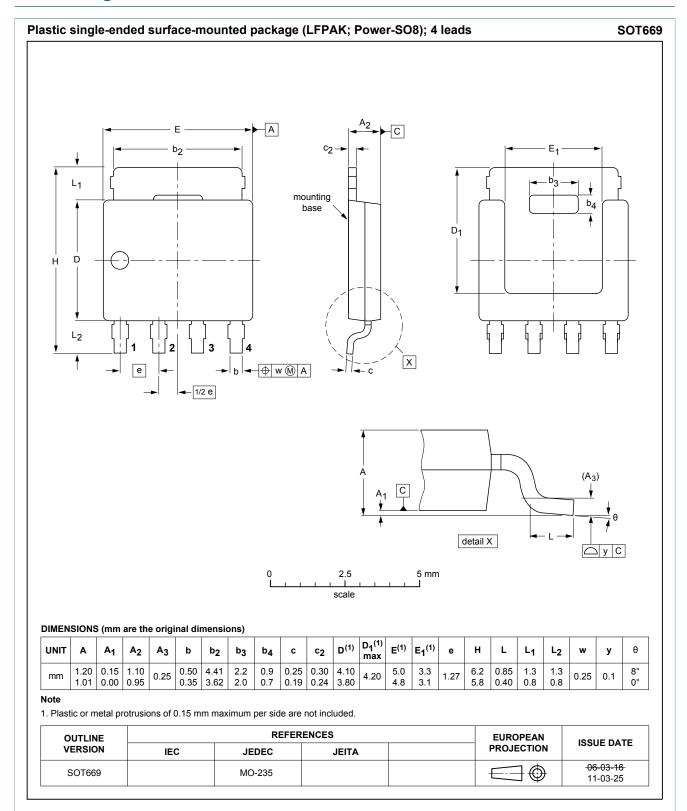


Fig. 19. Package outline LFPAK; Power-SO8 (SOT669)

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